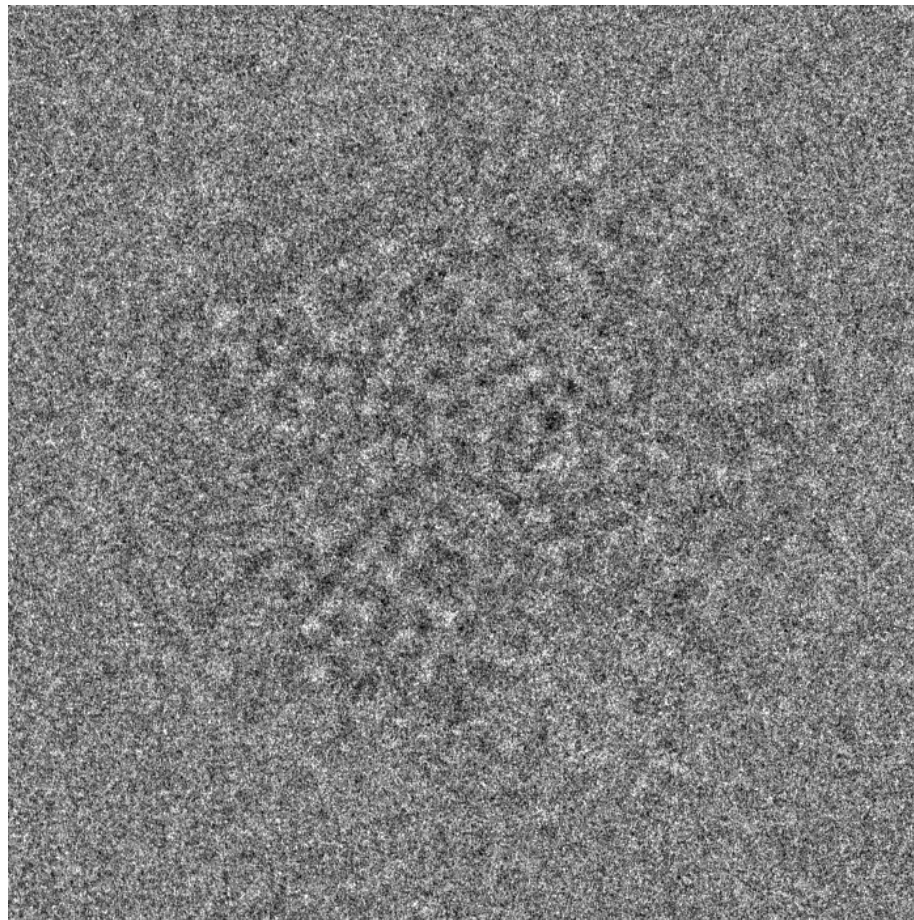
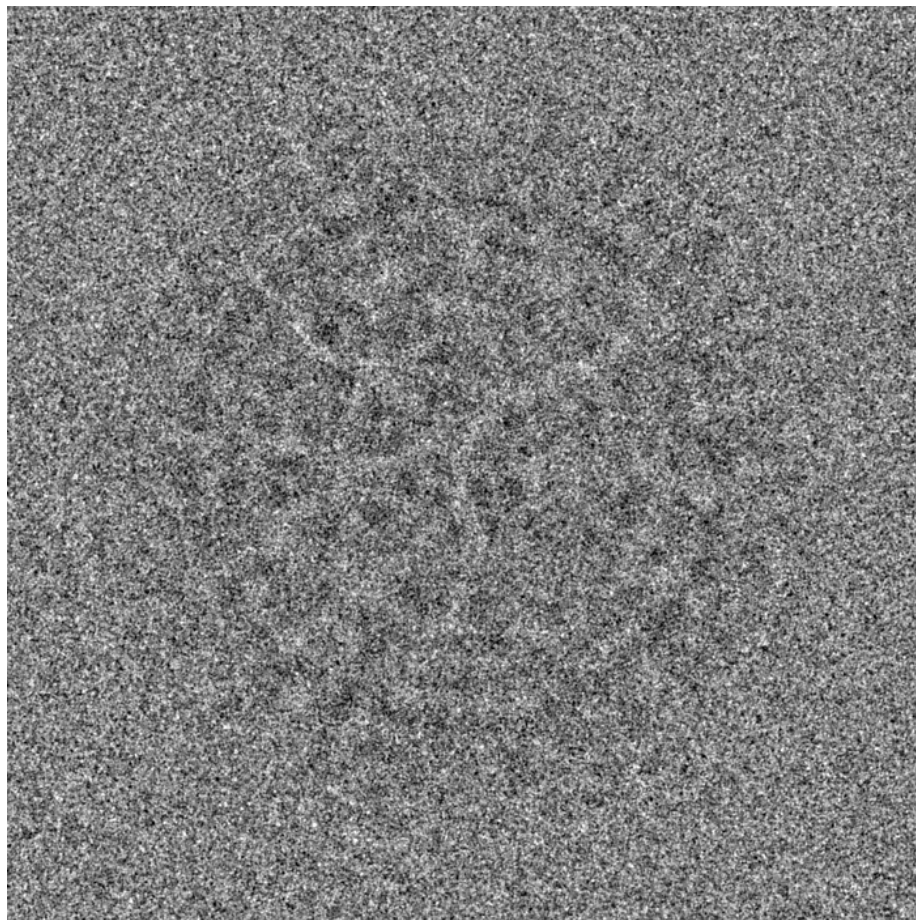


Correcting the Image

N. Grigorieff

What is “Wrong” with the Image?



Electron Diffraction

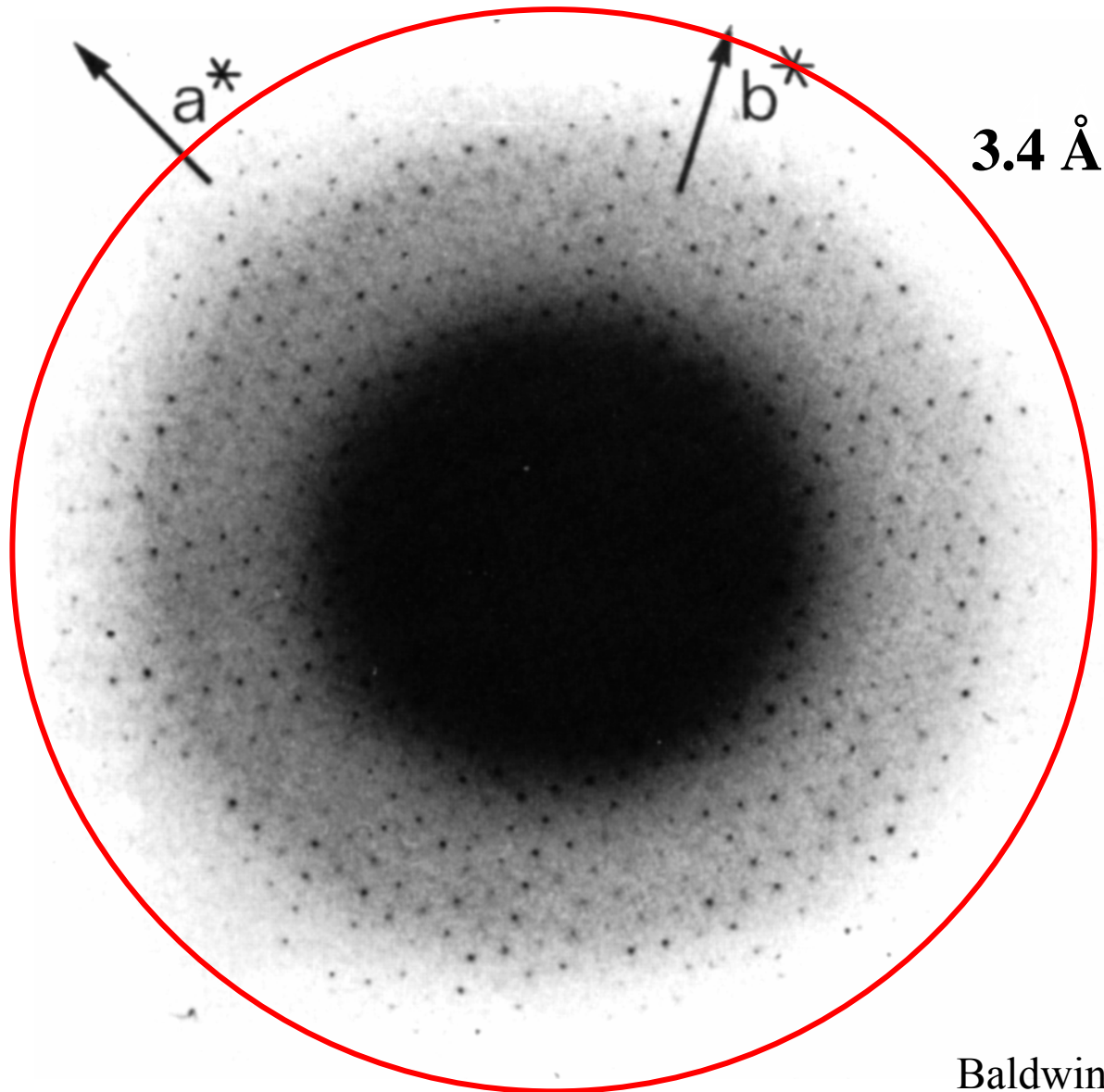
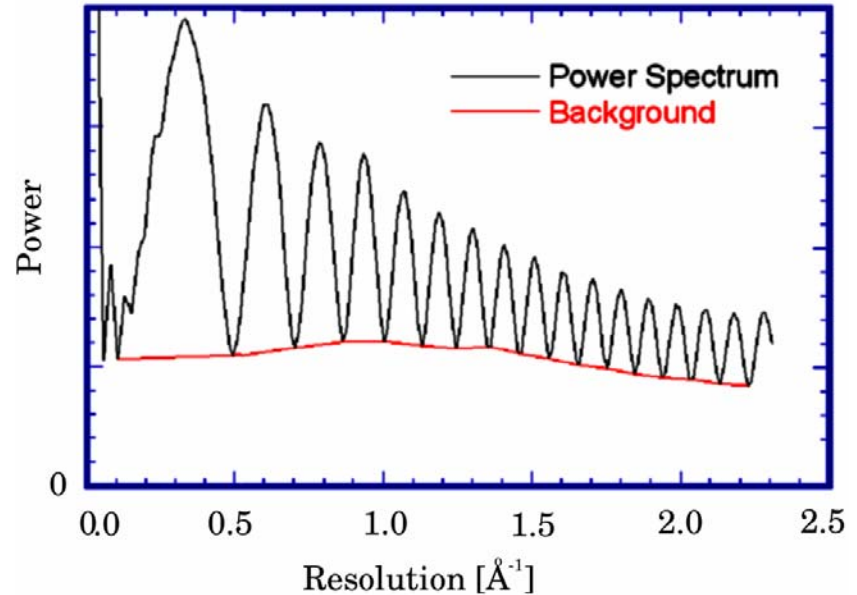
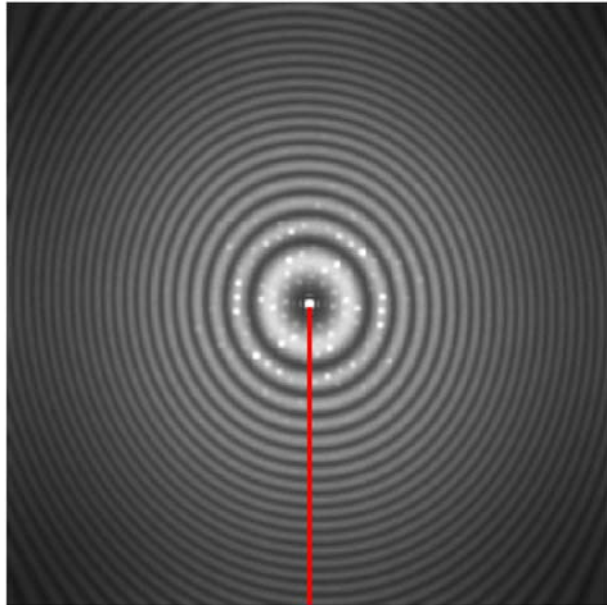


Image Contrast



$$P(\mathbf{k}) = [(S(\mathbf{k}) + B_i(\mathbf{k}))ENV_i(\mathbf{k})CTF(\mathbf{k})]^2 MTF^2(\mathbf{k})$$

S = signal

B_i = imaged background

ENV_i = CTF envelope

MTF = Detector MTF

$$+ B_s^2(\mathbf{k})MTF^2(\mathbf{k}) + B_e^2$$

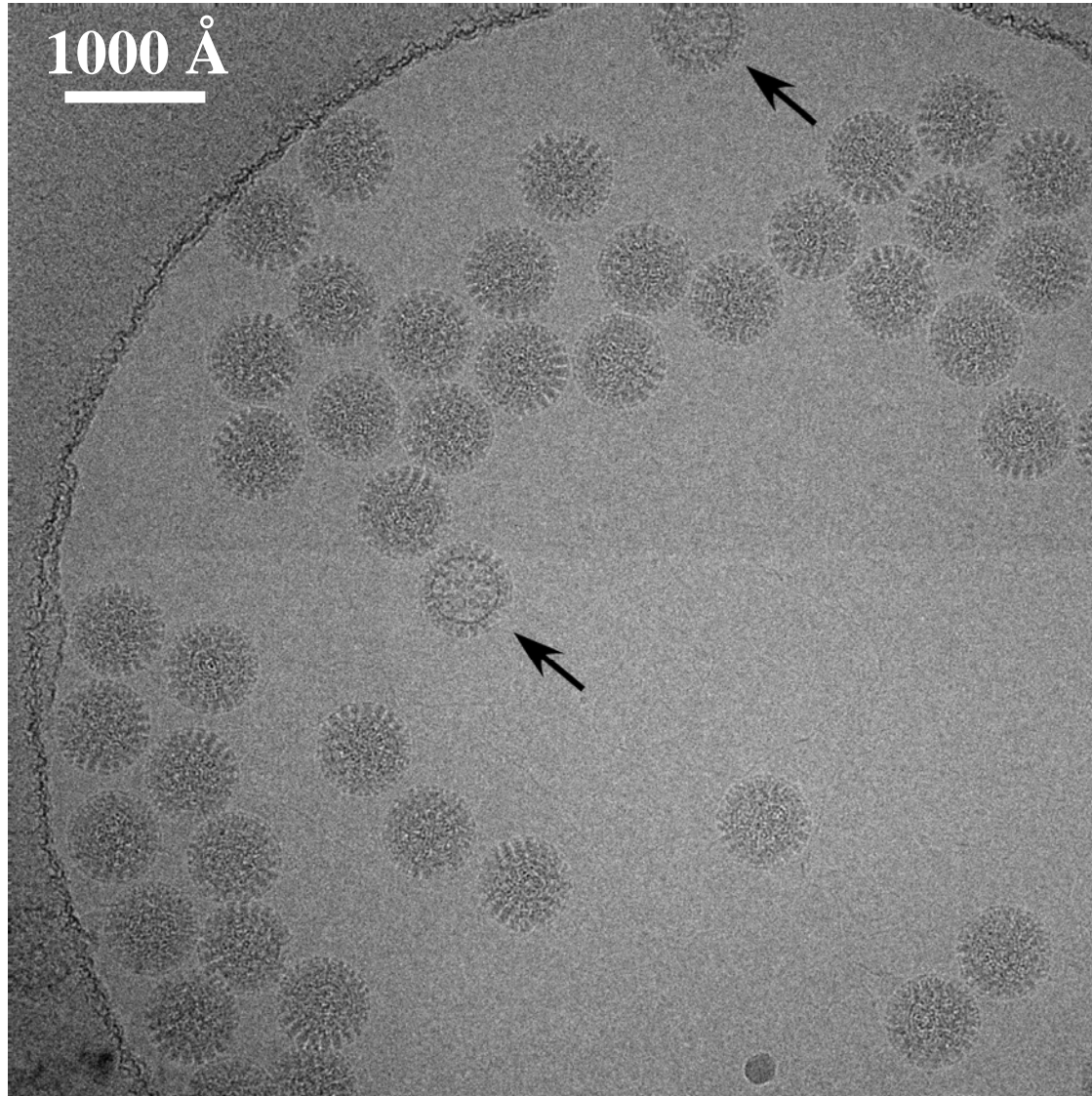
B_s = shot noise

B_e = detector noise

Things to Worry About

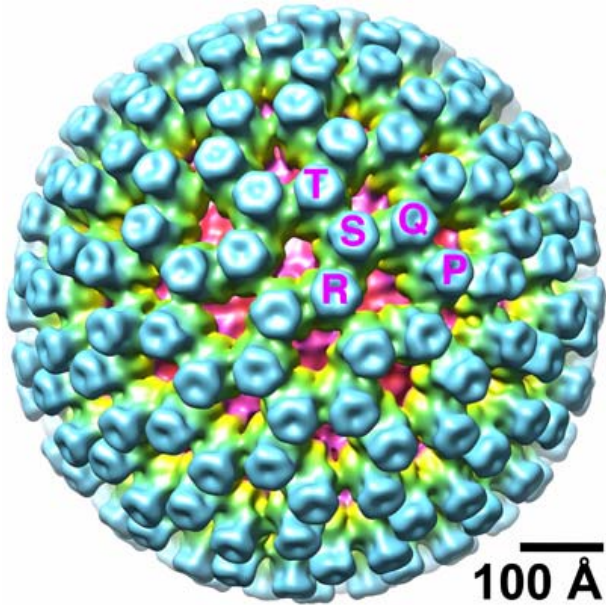
- Quality
 - Resolution, contrast
- Contrast transfer function
 - Defocus, astigmatism, beam tilt, envelope
- Magnification
 - Variations from image to image/within images
- Ewald sphere (for large objects)
- Contrast normalization
- Inelastic and multiple scattering
 - Energy filter, diffraction theory

Rotavirus Double-Layer Particles



Side Chains

Rotavirus
double-layer
particles



8400 particles

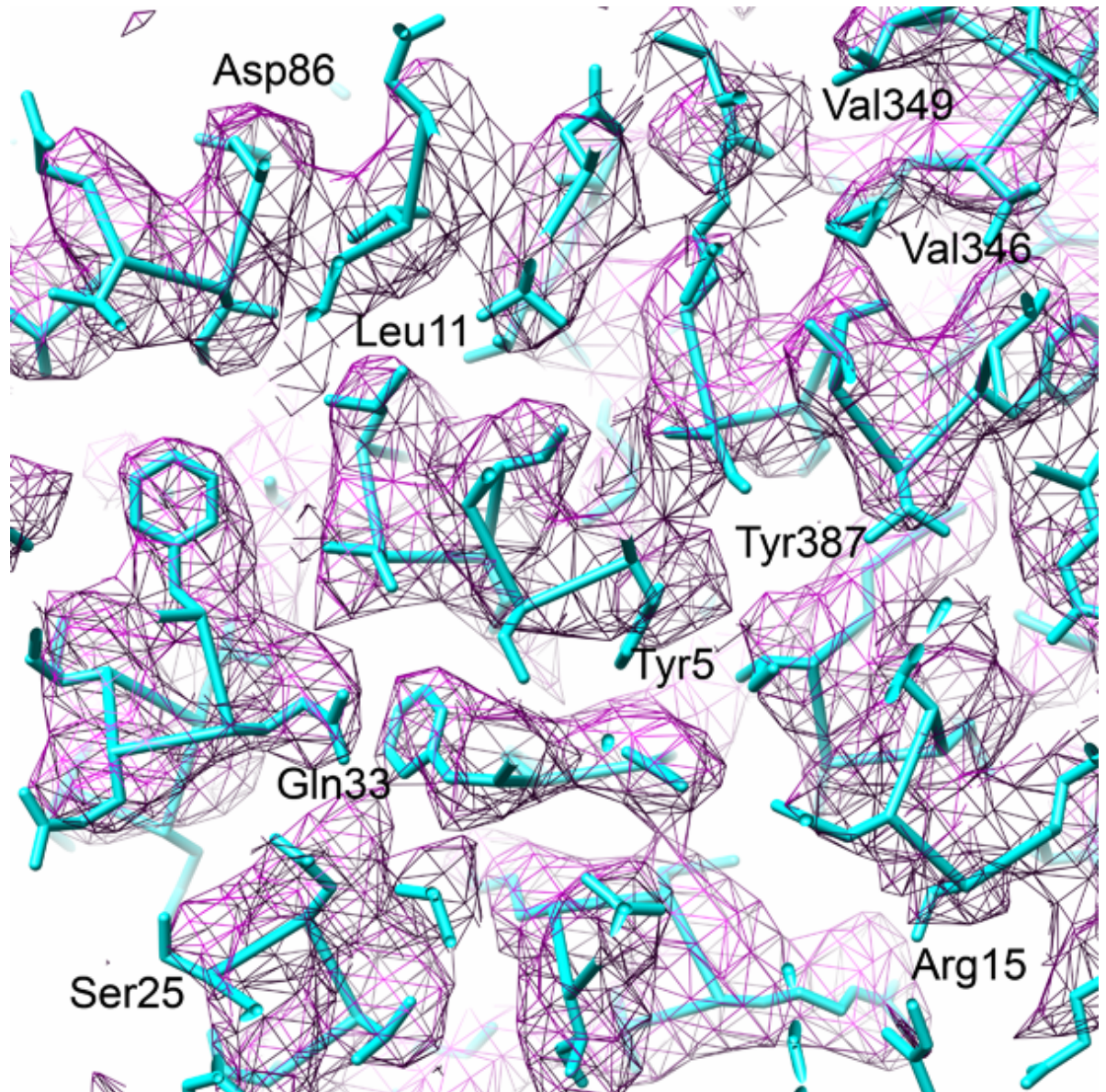


Image Quality - Grids

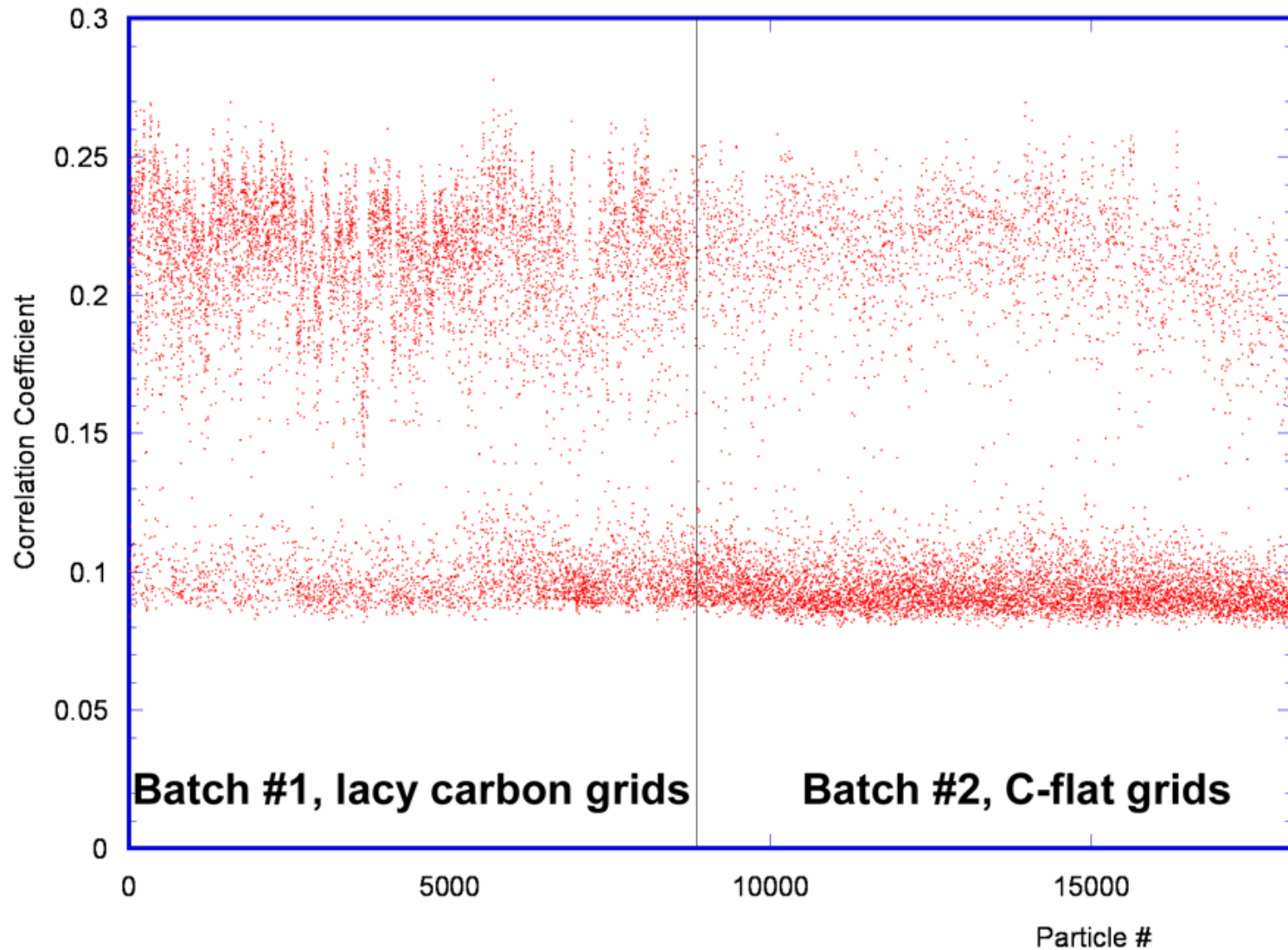


Image Quality – Location on Grid

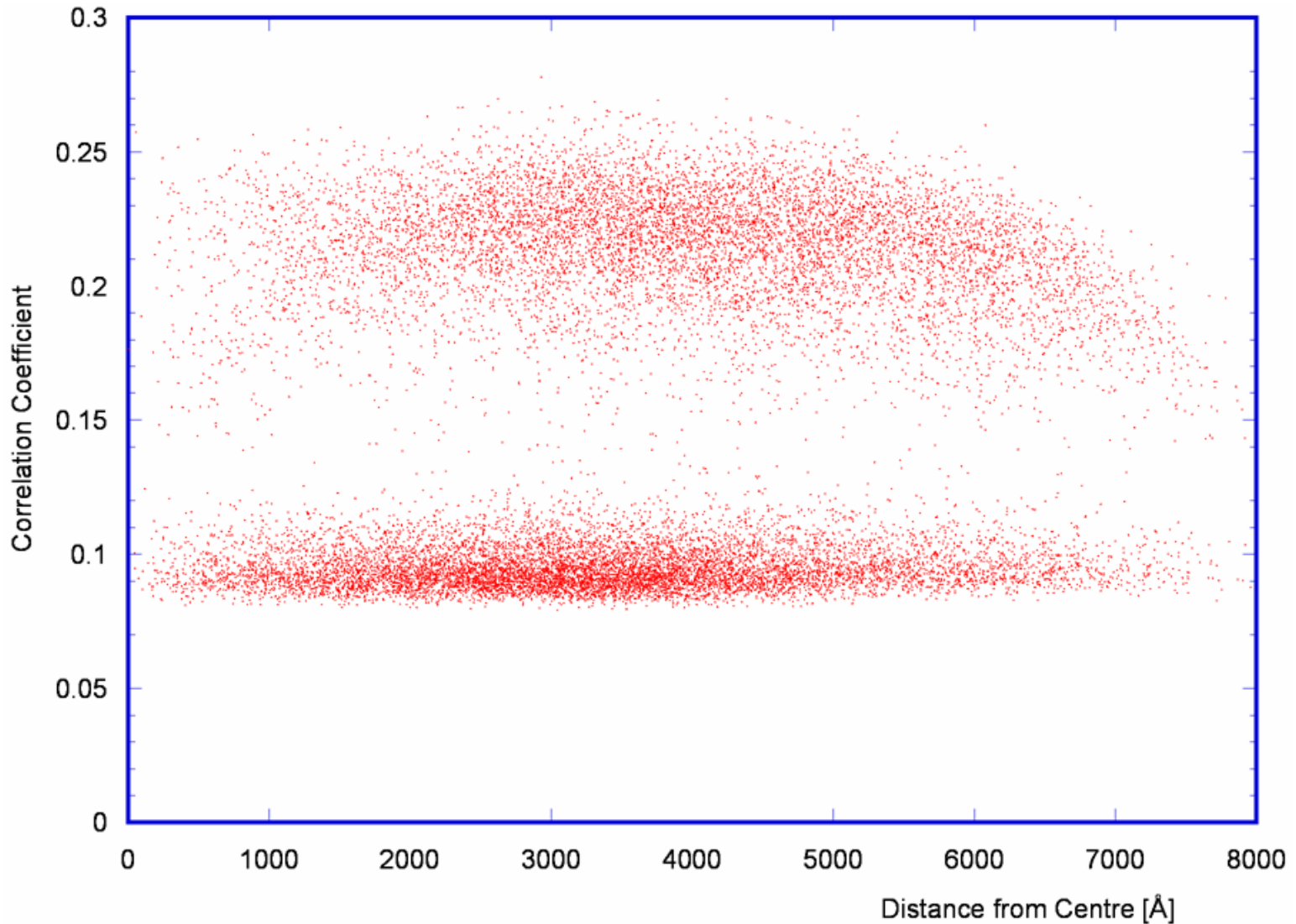
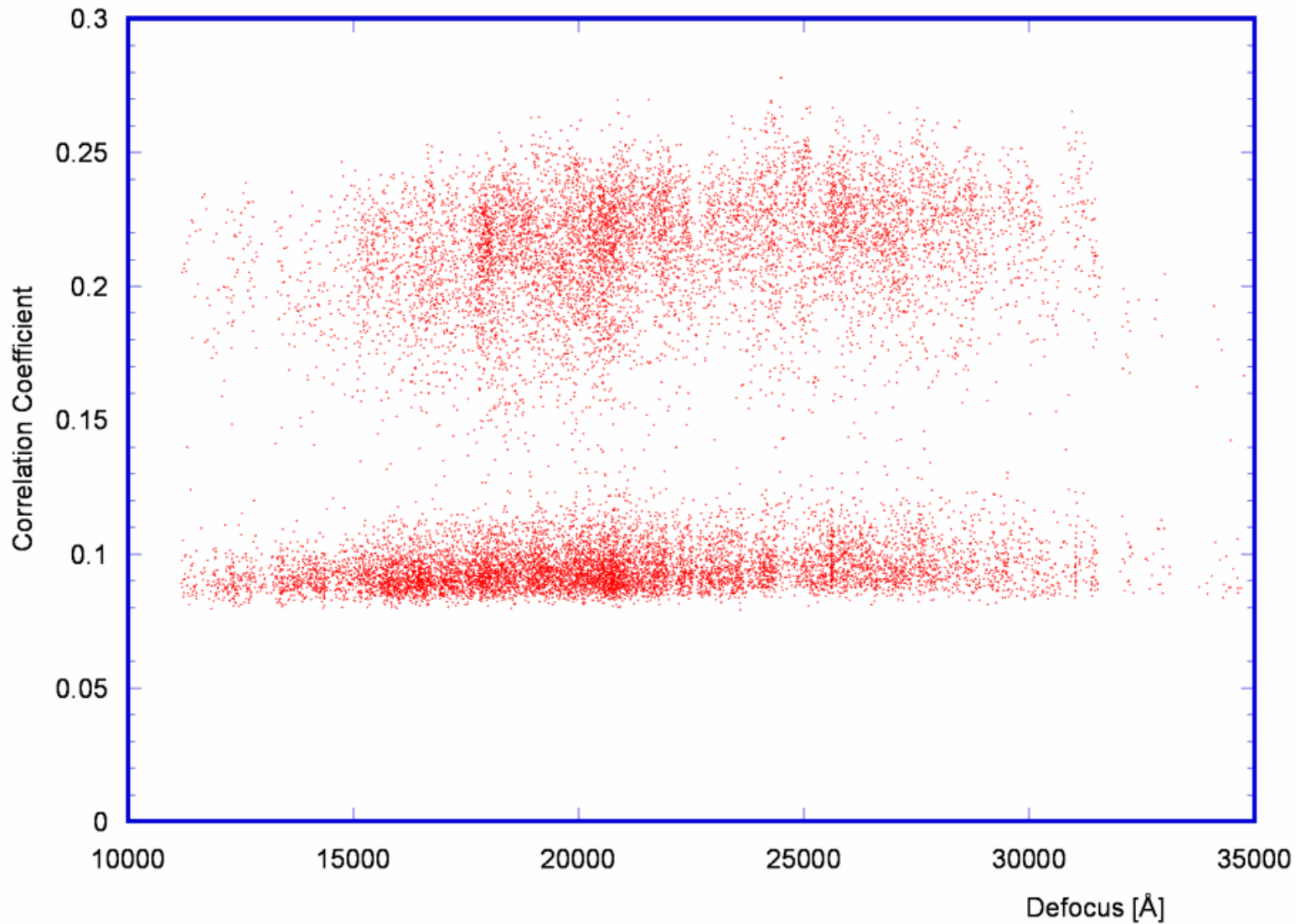
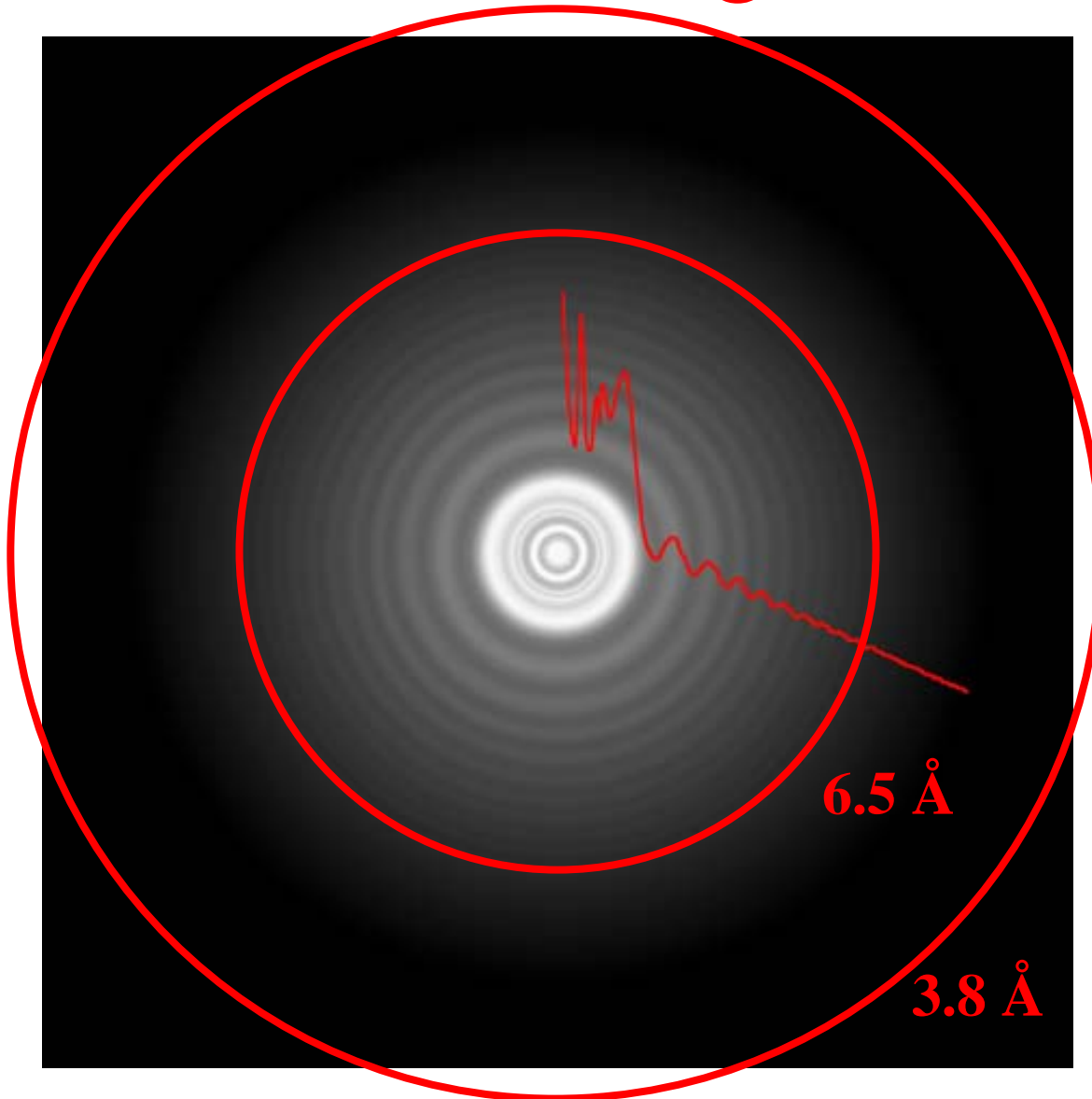


Image Quality - Defocus



Thin Rings



Determining the CTF

CTFFIND3

Model

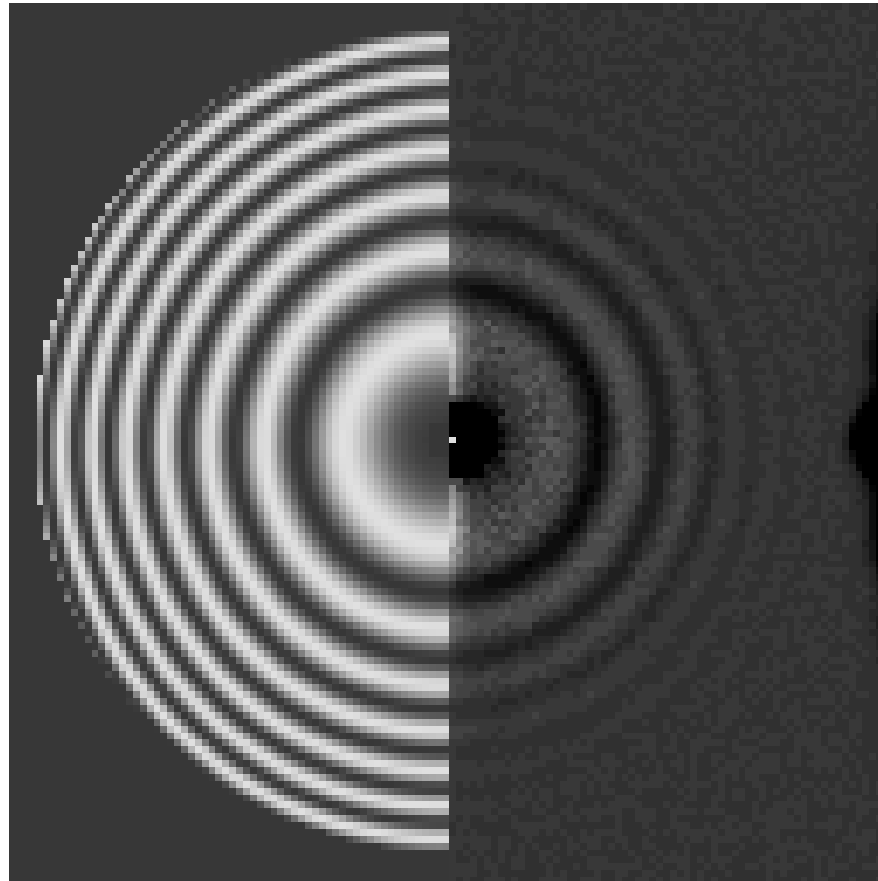
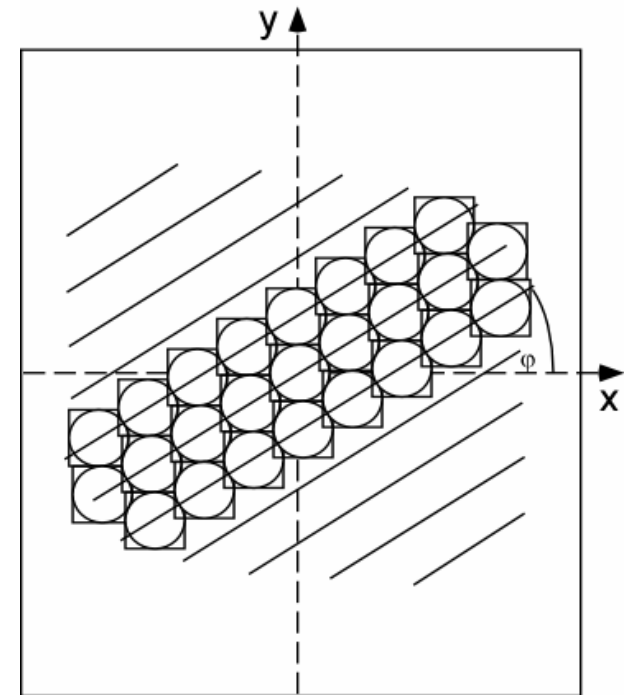
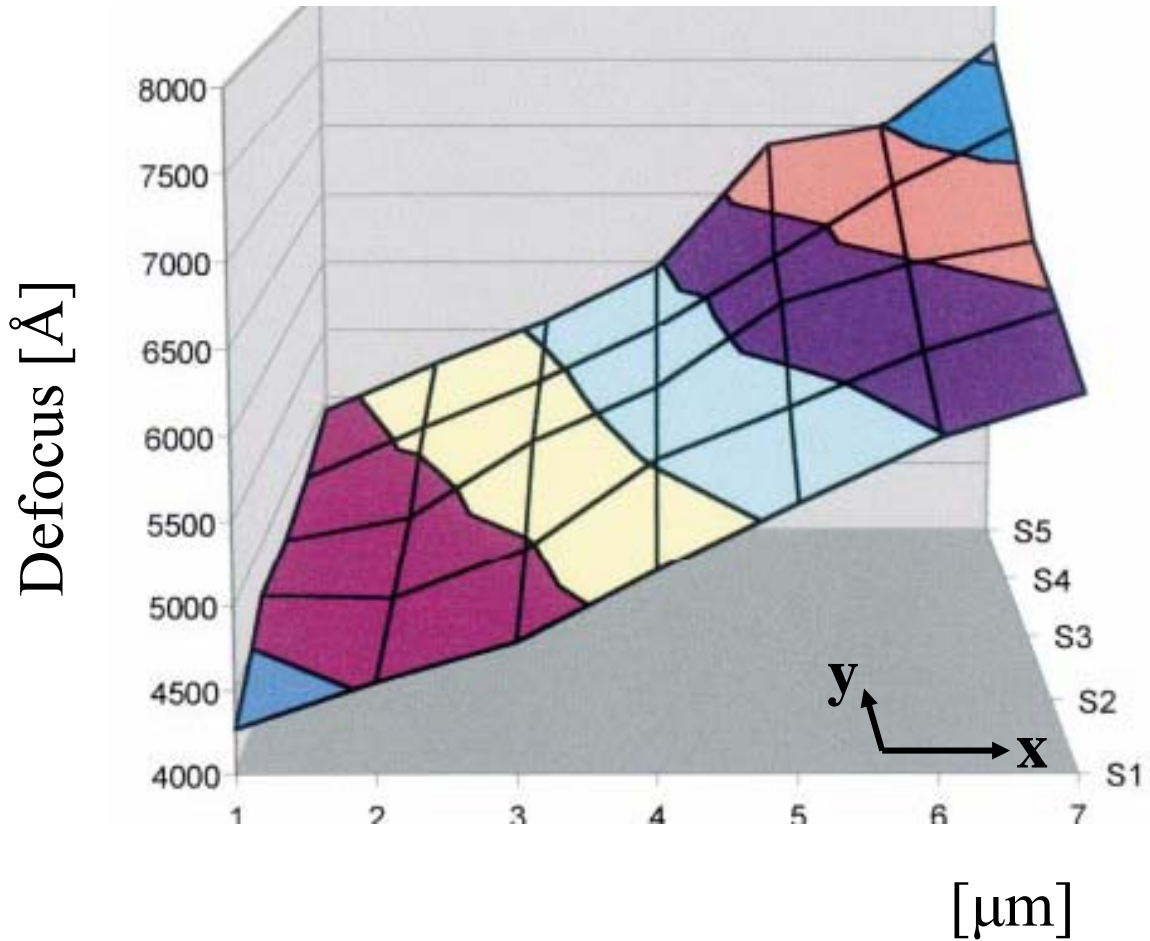


Image power
spectrum

Experiment

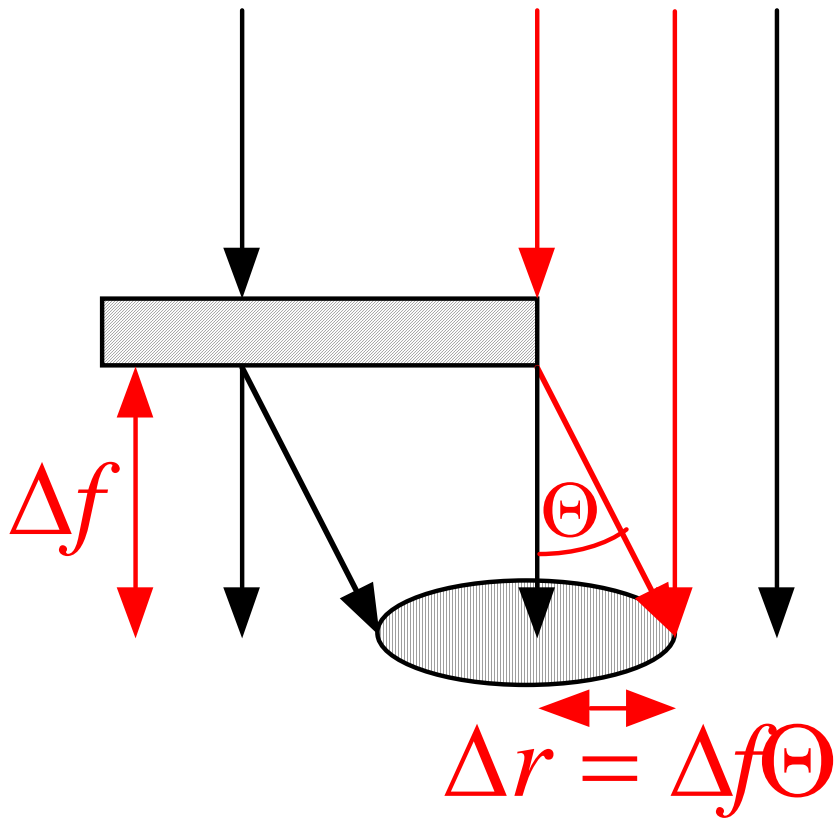
$$E = 120 \text{ kV}, \Delta f = 21000 \text{ \AA}, C_s = 2 \text{ mm}, A = 0.15$$

Defocus Gradient



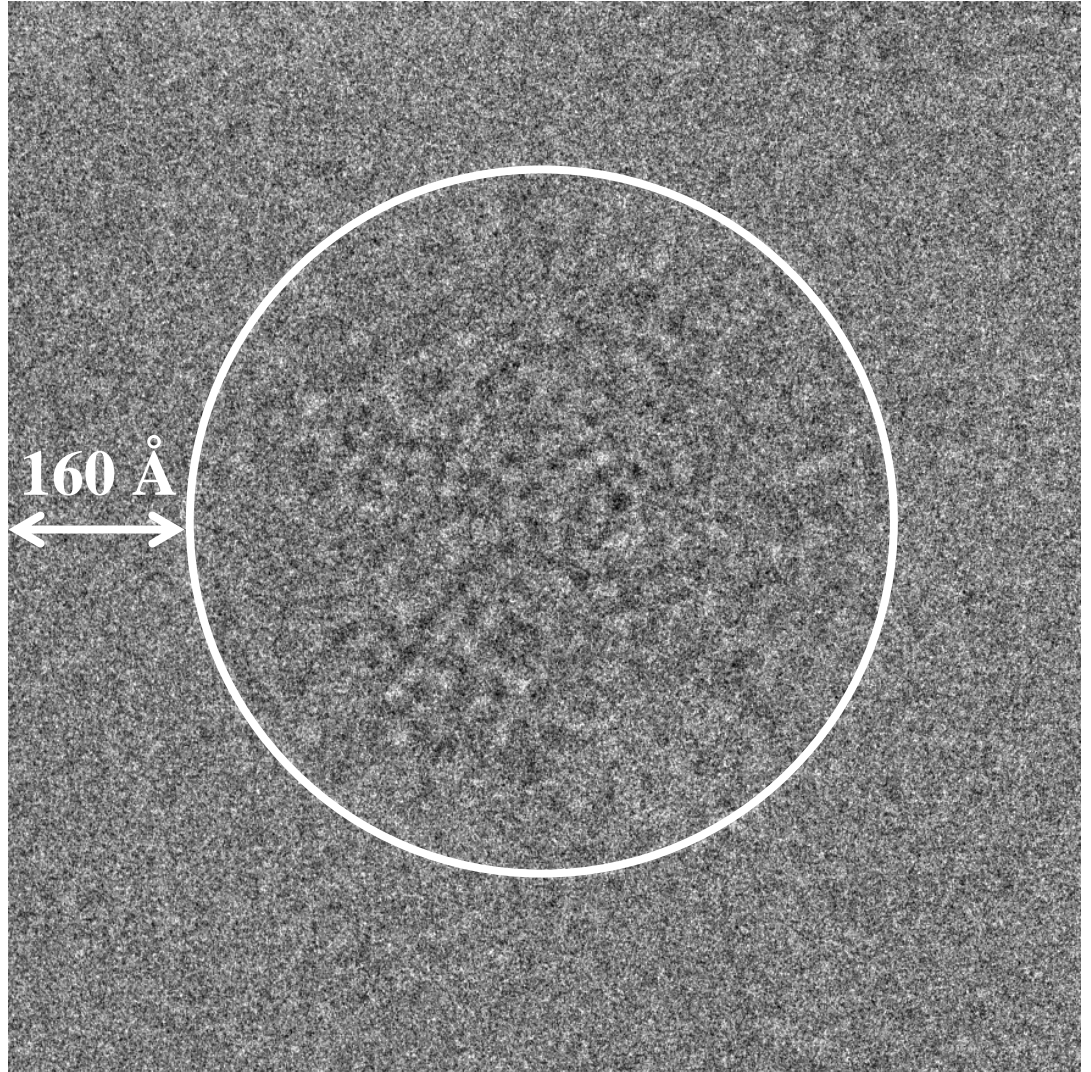
CTFTILT

Displaced Information

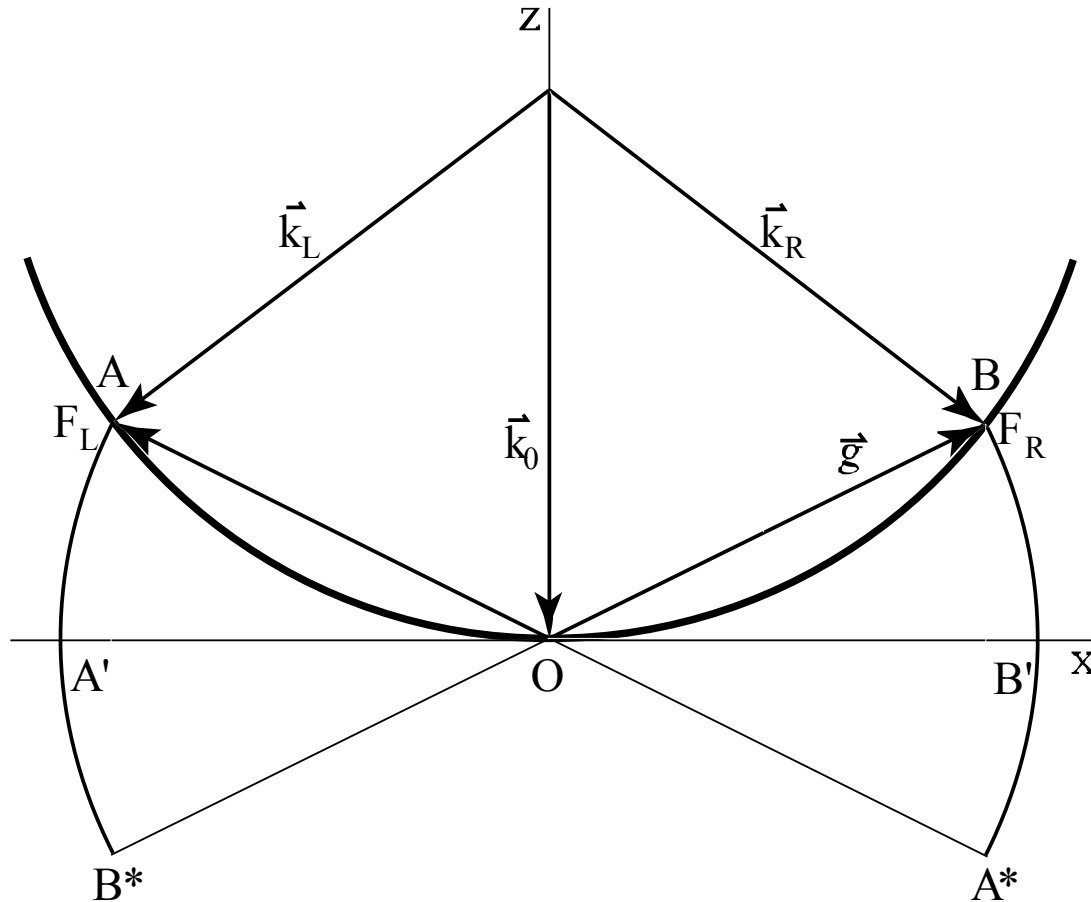


Margins

$$\begin{aligned}\Delta r &= \Delta f \Theta \\ &= 25000 \text{ \AA} \times 5.3 \text{ mrad} \\ &= 130 \text{ \AA}\end{aligned}$$



Ewald Sphere



Phase error = 60° for 700 \AA particle at 300 kV

Normalization

$$\hat{I}(x, y) = \frac{I(x, y) - \text{avg}(I)}{\sqrt{\text{var}(I)}}$$

$$\hat{I}(x, y) = \frac{I(x, y) - \text{avg}[\text{bg}(I)]}{\sqrt{\text{var}[\text{bg}(I)]}}$$

Maximum Likelihood

**Structure for
 $n+1$ iteration**

$$A^{(n+1)} = \frac{1}{N} \sum_{i=1}^N \frac{\int X_i(\phi) p_i(\phi, \Theta^{(n)}) d\phi}{\int p_i(\phi, \Theta^{(n)}) d\phi}$$

**Probability
function**

$$p_i(\phi, \Theta) = \left(\frac{1}{\sqrt{2\pi}\sigma} \right)^M \exp \left[-\frac{|X_i(\phi) - A|^2}{2\sigma^2} \right] f(\phi | \Theta)$$

X_i : i th image

Θ : model parameters

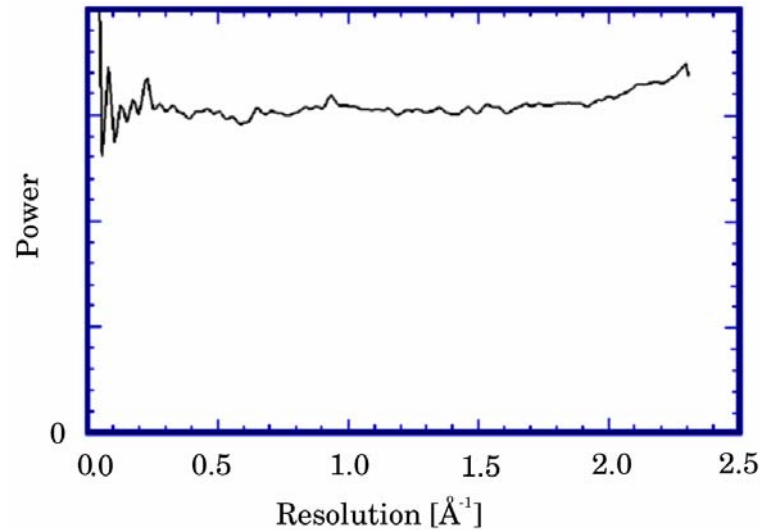
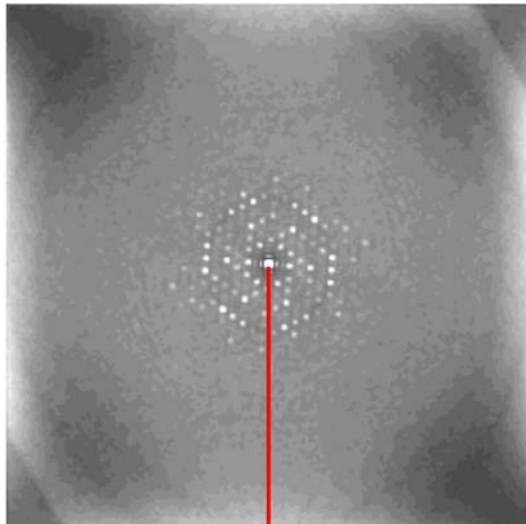
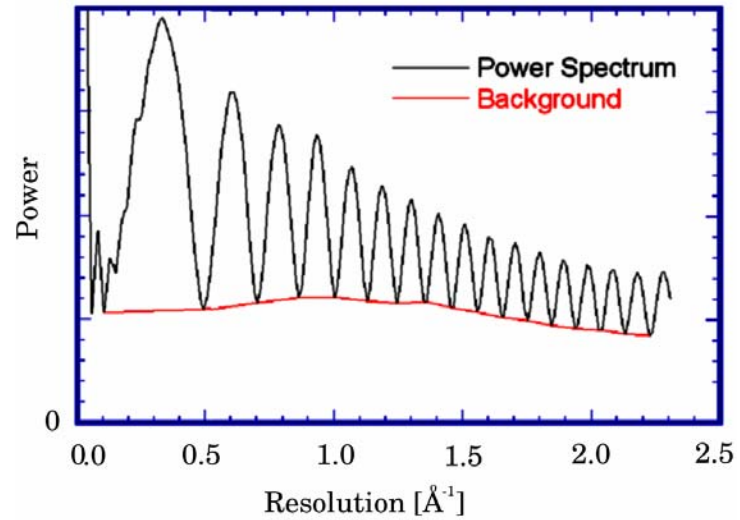
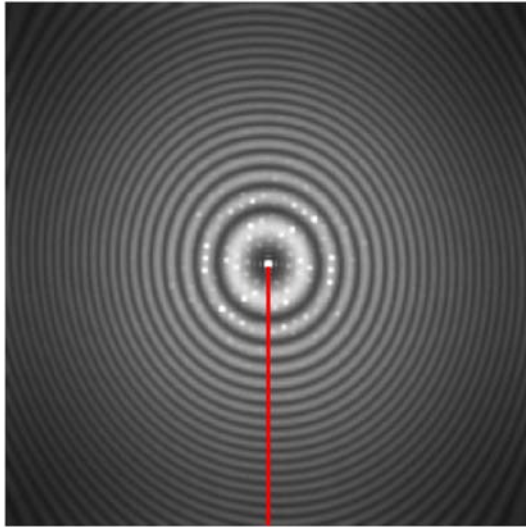
N : # of images

σ : noise in images

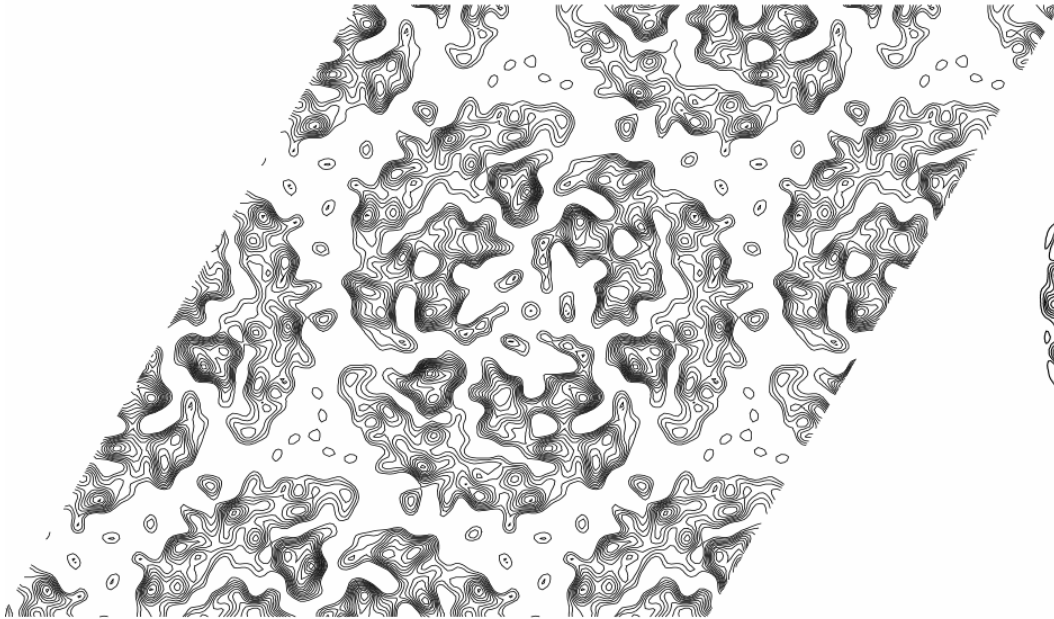
ϕ : alignment parameters

f : positional probab.

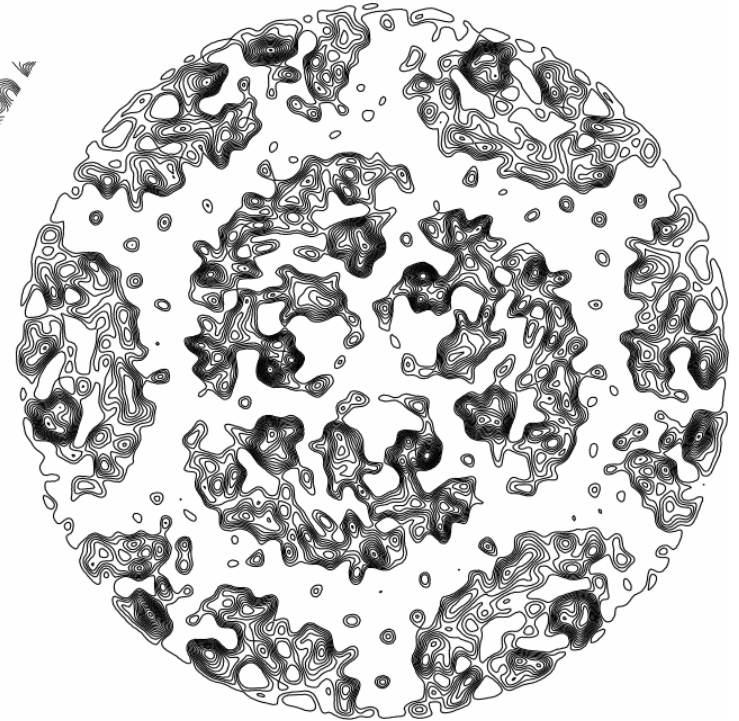
Noise Model



ML processing of 2D crystals

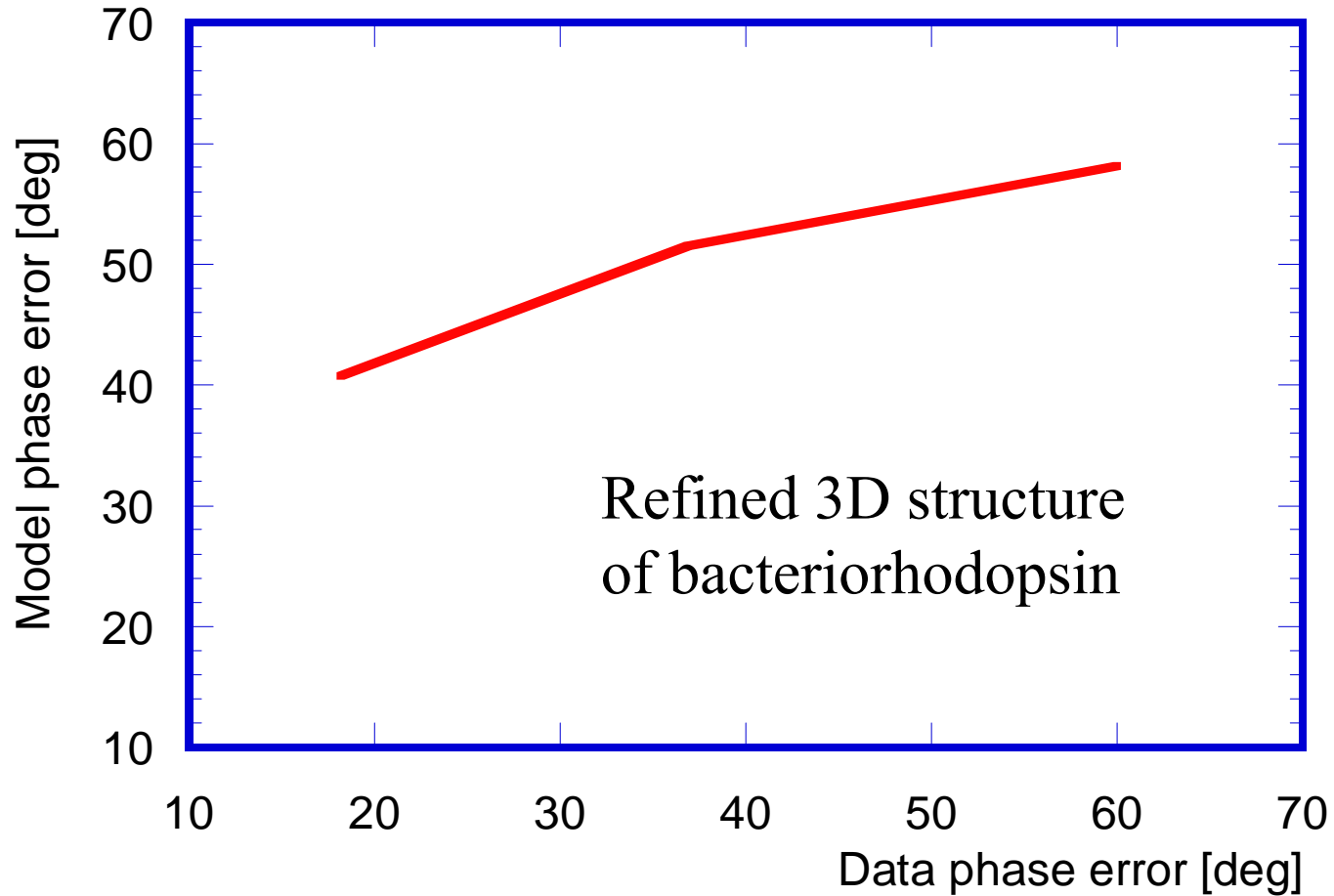


Crystallography

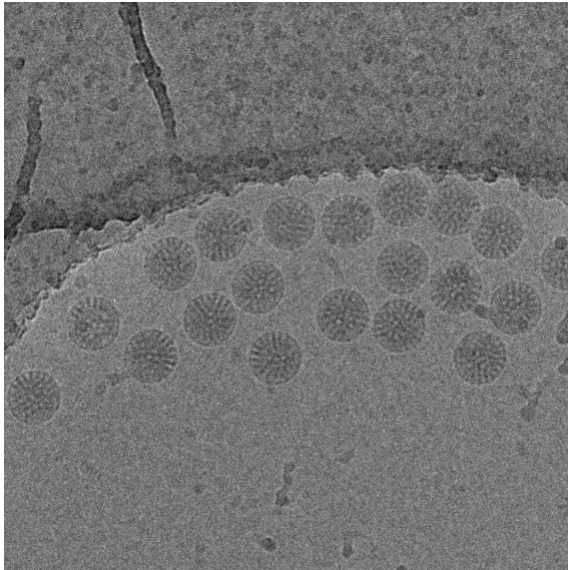


Alignment of
individual unit cells
using ML approach

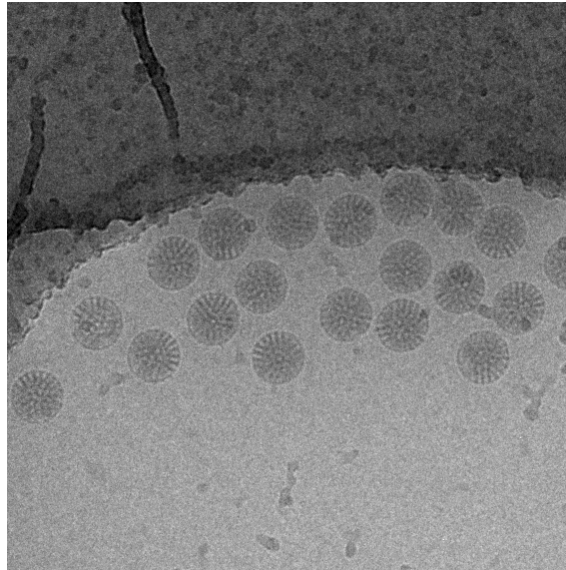
Systematic Error



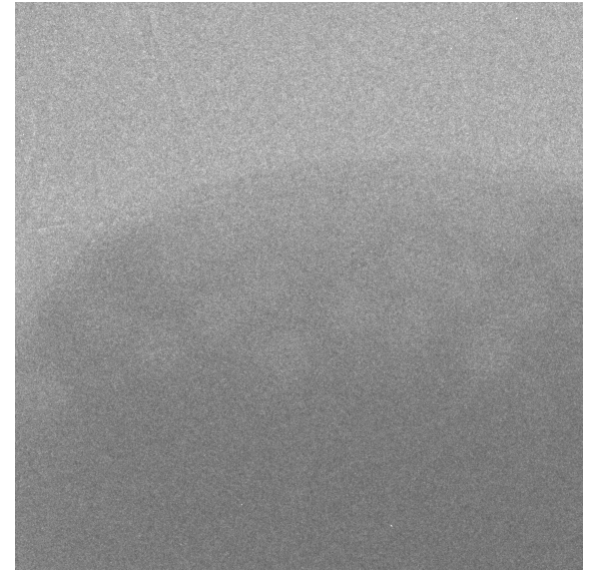
Inelastic Image



Unfiltered



0 eV



25 eV

300 kV, 6 μm underfocus, 15 eV energy window

Things to Worry About ?

- Quality
 - Resolution, contrast
- Contrast transfer function
 - Defocus, astigmatism, beam tilt, envelope
- Magnification
 - Variations from image to image/within images
- Ewald sphere (for large objects)
- Contrast normalization
- Inelastic and multiple scattering
 - Energy filter, diffraction theory

Acknowledgements

- Rotavirus DLP Xing Zhang, Ethan Settembre
(Harrison lab)
- Purple membrane Fritz Zemlin, Erich Beckmann
- ML of 2D crystals Xiangyan Zeng (Stahlberg lab)
- CTFFIND3/TILT Joe Mindell
- Ewald sphere Matthias Wolf, David DeRosier
- Inelastic scattering Chen Xu

- **Financial Support:** **HHMI, NIH, NSF**
Humboldt Foundation